

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/808,020 | Applicant(s)/Patent Under Reexamination DO ET AL. | |
| | Examiner Kevin M. Bernatz | Art Unit 1773 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| * | A | US-2003/0170499 | 09-2003 | Okamoto, Iwao | 428/694.0MM |
| * | B | US-5,851,643 | 12-1998 | Honda et al. | 428/212 |
| * | C | US-6,794,057 | 09-2004 | Wang et al. | 428/828.1 |
| * | D | US-6,811,890 | 11-2004 | Zhou et al. | 428/828.1 |
| * | E | US-6,828,036 | 12-2004 | Munteanu et al. | 428/828.1 |
| * | F | US-6,821,652 | 11-2004 | Okamoto et al. | 428/828.1 |
| * | G | US-2005/0190498 | 09-2005 | Do et al. | 360/135 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|-----------|----------------|
| | N | WO-03-065356-A1 | 08-2003 | WO | Do et al. | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.